



MJ N-Channel Enhancement Mode Power MOSFET

Description

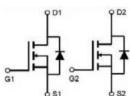
The MJ30ND09S uses advanced trench technology and design to provide excellent R_{DS(ON)} with low gate charge. It can be used in a wide variety of applications.

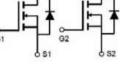
General Features

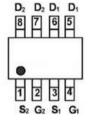
- ♦ V_{DS} =30V.I_D =9A $R_{DS(ON)}$ <12m Ω @ Vgs=10V $R_{DS(ON)} < 17 m\Omega$ @ $V_{GS} = 4.5V$
- ♦ High density cell design for ultra low Rdson
- ◆ Fully characterized avalanche voltage and current

Application

- ◆ Power switching application
- Hard switched and high frequency circuits
- Uninterruptible power supply









Schematic diagram

Marking and pin Assignment

SOP-8 top view

Package Marking and Ordering Information

Device Marking	Device	Device Package	Reel Size	Tape width	Quantity
30ND09S	MJ30ND09S	SOP-8	Ø330mm	12mm	4000 units

Absolute Maximum Ratings (T_A=25℃ unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	VDS	30	V
Gate-Source Voltage	Vgs	±20	V
Drain Current-Continuous	lo	9	А
Drain Current-Continuous(Tc =100°C)	ID(100°C)	6.4	А
Pulsed Drain Current	IDM	40	А
Maximum Power Dissipation	Po	2	W
Operating Junction and Storage Temperature Range	Тл ,Тѕтс	-55 To 150	°C

Thermal Characteristic

Parameter	Symbol	Тур	Max	Unit
Thermal Resistance, Junction-to-Ambient (Note 2)	RөJA	62.5	85	°C/W





Electrical Characteristics (Tc=25℃ unless otherwise noted)

Parameter	Symbol	Condition	Min	Тур	Max	Unit
Off Characteristics						
Drain-Source Breakdown Voltage	BVDSS	V _{GS} =0V I _D =250µA	30	-	-	V
Zero Gate Voltage Drain Current	loss	V _{DS} =30V,V _{GS} =0V	-	-	1	μΑ
Gate-Body Leakage Current	lgss	V _{DS} =±20V,V _{DS} =0V	-	-	±100	nA
On Characteristics (Note 3)						
Gate Threshold Voltage	VGS(th)	V _{DS} =V _{GS} ,I _D =250μA	1.0	1.6	2.2	V
		V _{GS} =10V, I _D =6A	-	10.3	12.0	mΩ
Drain-Source On-State Resistance	Rds(on)	V _{GS} =4.5V, I _D =4A		13.9	17.0	mΩ
Forward Transconductance	g FS	V _{DS} =5V,I _D =6A	26	-	-	S
Dynamic Characteristics (Note 4)	1	1	1	1	ı	
Input Capacitance	Clss		-	1210	-	PF
Output Capacitance	Coss	V _{DS} =15V,V _{GS} =0V F=1.0MHz	-	160	-	PF
Reverse Transfer Capacitance	Crss	-	-	105	_	PF
Switching Characteristics (Note 4)	1					
Turn-on Delay Time	t _{d(on)}		-	5	-	nS
Turn-on Rise Time	tr	V _{DD} =15V, R _L =0.75Ω	-	12	-	nS
Turn-Off Delay Time	t _{d(off)}	$V_{GS}=10V,R_{G}=3\Omega$	-	19	-	nS
Turn-Off Fall Time	tf	-	-	6	-	nS
Total Gate Charge	Qg		-	17.5	-	nC
Gate-Source Charge	Qgs	V _{DS} =15V,I _D =6A V _{GS} =10V	-	3	-	nC
Gate-Drain Charge	Qgd	_	-	4.1	-	nC
Drain-Source Diode Characteristics						
Diode Forward Voltage (Note 3)	VsD	V _{GS} =0V,I _S =6A	-	-	1.2	V
Diode Forward Current (Note 2)	ls		-	_	9	А
Reverse Recovery Time	trr	T1-25°C 15-64	-	19	-	nS
Reverse Recovery Charge	Qrr	TJ=25°C, IF=6A di/dt=100A/µs (Note 3)	-	10	_	nC
Forward Turn-On Time	ton	Intrinsic turn-on time is negligible(turn-on is dominated by L				

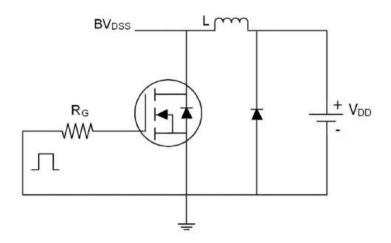
Notes:

- ① Repetitive Rating: Pulse width limited by maximum junction temperature.
- ② Surface Mounted on FR4 Board, $t \le 10$ sec.
- 3 Pulse Test: Pulse Width \leq 300 μ s, Duty Cycle \leq 2%.
- 4 Guaranteed by design, not subject to production
- \bigcirc EAS condition:Tj=25 $^{\circ}$ C,Vpp=15V,Vg=10V,L=0.5mH,Rg=25 Ω

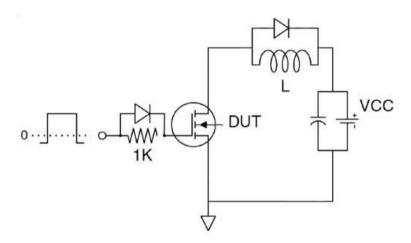




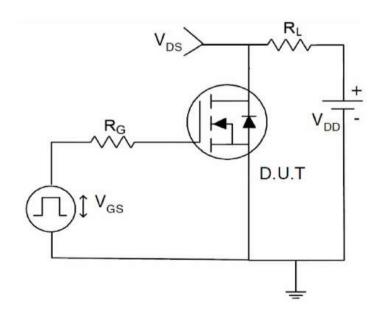
Test circuit



Eas test Circuit



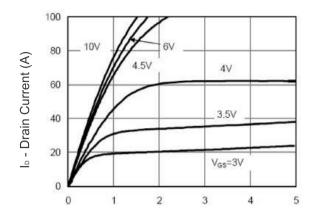
Gate charge test Circuit



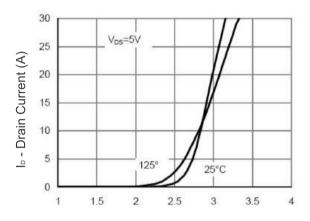
Switch Time Test Circuit



Typical Electrical and Thermal Characteristics (Curves)



Vds Drain-Source Voltage (V)
Figure 1 Output Characteristics



Vgs Gate-Source Voltage (V)
Figure 2 Transfer Characteristics

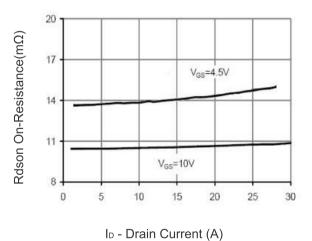
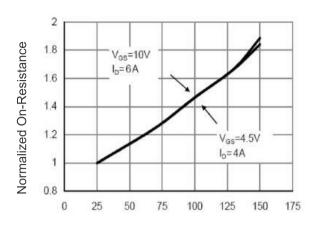
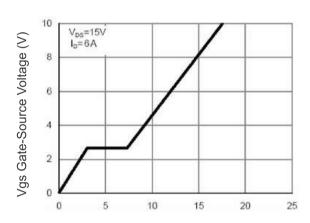


Figure 3 Rdson- Drain Current

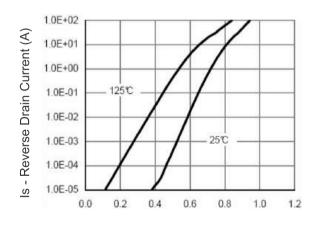


T_J -Junction Temperature(°C)

Figure 4 Rdson-Junction Temperature

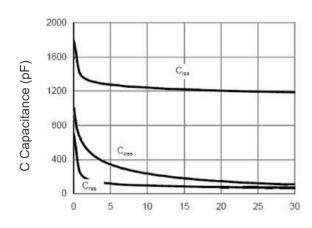


Qg Gate Charge (nC)
Figure 5 Gate Charge

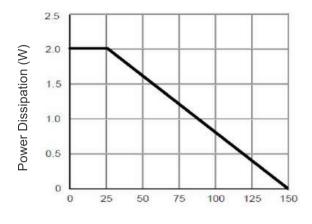


Vsd Source-Drain Voltage (V)
Figure 6 Source- Drain Diode Forward





Vds Drain-Source Voltage (V)
Figure 7 Capacitance vs Vds



T_J -Junction Temperature(°C)
Figure 9 Power De-rating

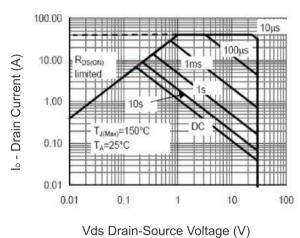
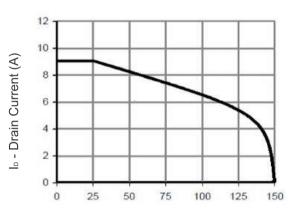
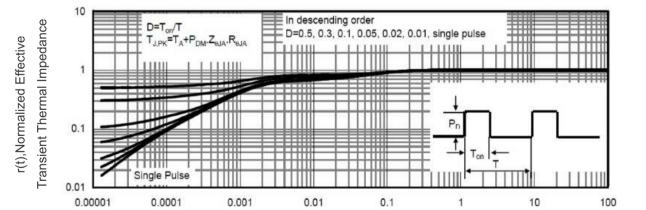


Figure 8 Safe Operation Area



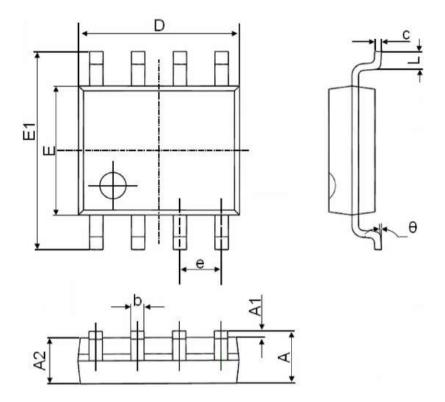
T_J -Junction Temperature(°C)
Figure 10 I_D Current De-rating



Square Wave Pluse Duration(sec)

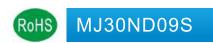
Figure 11 Normalized Maximum Transient Thermal Impedance

SOP-8 Package Information



Combal	Dimensions In Millimeters		Dimensions In Inches		
Symbol	Min.	Max.	Min.	Max.	
Α	1.350	1.750	0.053	0.069	
A1	0.100	0.250	0.004	0.010	
A2	1.350	1.550	0.053	0.061	
b	0.330	0.510	0.013	0.020	
С	0.170	0.250	0.006	0.010	
D	4.700	5.100	0.185	0.200	
E	3.800	4.000	0.150	0.157	
E1	5.800	6.200	0.228	0.244	
е	1.270(BSC)		0.050	(BSC)	
L	0.400	1.270	0.016	0.050	
е	0°	8°	0°	8°	





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